

Structure and stability of Ba-Cu-Ge type-I clathrates

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We have prepared samples of nominal type $\text{Ba}_8\text{Cu}_x\text{Ge}_{46-x}$ by induction melting and solid state reaction. Analysis shows that these materials form type-I clathrates, with copper content between $x = 4.9$ and 5.3 , nearly independent of the starting composition. We used x-ray powder diffraction and single-crystal electron diffraction to confirm the cubic type-I clathrate structure, while electron microprobe measurements confirmed the stability of the $x \approx 5$ composition. This result differs from the corresponding Ag and Au clathrates, and was not known previously due perhaps to the similar Cu and Ge form factors in x-ray diffraction. The observed composition adheres very tightly to a valence-counting scheme, in agreement with a Zintl-type stability mechanism. This implies a gap in the electronic density of states, also in contrast to the metallic behavior of the Au and Ag analogs. Magnetization measurements showed a large diamagnetic response in the Ba-Cu-Ge clathrate. This behavior is consistent with semiconducting or semimetallic behavior, and is similar to that of a number of intermetallic semiconductors.

I. INTRODUCTION

Silicon, germanium, and tin form clathrate phases having framework structures in which the cages enclose single ions of the alkali metal, alkali earth, rare earth or halogen series.^{1,2,3} Doping with metal atoms has led to a wide variety of electronic behavior, including superconductivity in $\text{Ba}_8\text{Si}_{46}$,⁴ and in $\text{Ba}_8\text{Ga}_{16}\text{Ge}_{30}$,⁵ ferromagnetism in $\text{Ba}_8\text{Mn}_2\text{Ge}_{44}$,⁶ and a number of semiconducting compositions including the silicon-only material Si_{136} .⁷ There has been considerable interest in these materials, for a number of potential applications including thermoelectric cooling.^{2,3,8} There is the further potential for epitaxial growth in conventional semiconductor systems,⁹ and transition-metal and rare-earth-doped clathrates offer the possibility of new magnetic semiconductors.

We have studied the formation of Ba-Cu-Ge clathrates, and report on the stable formation of clathrates with the type-I structure and compositions close to $\text{Ba}_8\text{Cu}_5\text{Ge}_{40}$. This composition forms preferentially for a range of starting compositions, for ambient-pressure synthesis. The formation of Ba-Cu-Ge type-I clathrates has been reported previously.¹⁰ It is known that Cu substitutes for Ge on framework sites, although the nearness of Cu and Ge in the periodic table makes identification of specific Cu atomic positions via x-ray analysis somewhat difficult.

In type-I germanium-barium clathrates, of nominal composition $\text{Ba}_8\text{Ge}_{46}$, germanium occupies three sites, which are Wyckhoff $6c$, $16i$, and $24k$ sites in the cubic $\text{Pm}\bar{3}\text{n}$ (#223) structure. This structure is the analog of the $(\text{Cl}_2)_8(\text{H}_2\text{O})_{46}$ gas clathrate.² Ba ions occupy $2a$ and $6d$ sites, corresponding to locations within the two distinct cages of the Ge framework. A stable Ba-Ge type-I clathrate of composition $\text{Ba}_8\text{Ge}_{43}$, with three framework vacancies per unit cell, has been prepared and found to be semiconducting.¹¹ The analogous Ba-Sn clathrate is predicted to be stable in the composition $\text{Ba}_8\text{Sn}_{42}$.¹² The latter can be understood in terms of the Zintl-Klemm concept,¹³ assuming that each Ba donates two electrons

to the framework, satisfying the tetrahedral bonding requirements of the framework with four electrons per site, including vacancies. Semiconducting $\text{Ba}_8\text{Ge}_{43}$ has one less vacancy per cell than given by this argument, perhaps due to a slightly smaller electron transfer from Ba.¹¹

A number of transition metals have been incorporated into Ge and Si clathrates,¹⁰ predominantly by substitution at the $6c$ site. Au and Ag-doped Ba-Si clathrates have recently been reported with a range of doping levels, exhibiting metallic and superconducting behavior.^{14,15} Thus, these materials must lie outside the range of stabilization via bond filling, of the Zintl type as seen in other clathrates. Au-doped Ba-Ge clathrate has also been reported to be metallic.¹¹ Hence by analogy we expected the Cu-doped Ba-Ge clathrate to be a metal with a range of stable composition, although the initial report described only $\text{Ba}_8\text{Cu}_6\text{Ge}_{40}$.¹⁰ However, our results show that Cu prefers to substitute in a relatively narrow range of composition, as detailed below. Furthermore, magnetic and transport measurements indicate this material to be semimetallic, in contrast to the Au analog, and in the Analysis and Discussion section we show that a bond filling mechanism provides a good accounting for the stability of this phase.

II. EXPERIMENT

Ingots with nominal compositions $\text{Ba}_8\text{Cu}_x\text{Ge}_{46-x}$, for $x = 2, 4$ and 6 , were formed by rf induction melting and solid-state reaction. These samples will be referred to as Cu2, Cu4, and Cu6, respectively. Stoichiometric quantities of the elemental materials were finely powdered and pressed into BN crucibles, then induction heated in an argon atmosphere. The resulting ingots, exhibiting a metallic luster, were further reacted at 950°C for 3 days followed by 700°C for 4 days, in evacuated ampoules. SEM and EDS analysis for the Cu2 and Cu6 samples showed these ingots to consist of large clathrate crystallites of typical size several-100 μm , with smaller

crystallites of other phases. The outer portion of these ingots was physically separated, and the central portion reserved for x-ray and magnetization measurements, giving a sample somewhat more concentrated in clathrate. Microprobe measurements were carried out on samples of the entire ingots.

Analysis by Cu $K\alpha$ powder x-ray diffraction showed characteristic type-I clathrate reflections, with a few percent diamond-structure Ge in the Cu2 and Cu4 samples. LeBail extraction and Rietveld refinement were performed using GSAS software,^{16,17} giving lattice constants steadily decreasing with increasing nominal Cu concentration. The refinement process is rather insensitive to the difference between Cu and Ge, due to their nearness in the periodic table. Therefore, for better determination we used electron microprobe results, described below, to constrain the Cu/Ge ratio in the clathrate during the x-ray fitting process. Furthermore, in the fit we assumed the Cu to be located only on the 6*c* site, as reported for other transition-metal Ge clathrates. Fig. 1 shows an x-ray fit thus obtained.

X-ray analysis results are summarized in Table I, with the trend in some of the structural parameters also plotted in Fig. 2. We found that the Cu starting composition had a rather small effect on the resulting Cu and vacancy concentrations in the clathrate, with the Cu content very close to 5 per cell in all cases. The lattice constant exhibited a small decrease with increasing Cu content (Fig. 2). These results are consistent with those of Ref. 10; values from that work are shown as filled squares in Fig. 2, placed at $x=6$, which was the starting composition for that study. Bond lengths in Fig. 2 show some sample-to-sample variation. Error bars are smaller than this variation. We used isotropic thermal parameters for these fits, and found the largest thermal parameter ($U_{iso} \approx 0.03$) for the Ba 6*d* site, occupying the larger cage, consistent with previous work on Ge clathrates.

The parameters x , y , and z in Table I are those for the Pm $\bar{3}$ n (#223) structure; the 16*i* position is given by (x, x, x) , and the 24*k* position, $(0, y, z)$. These parameters change very little with composition, and the 6*c* site remains close to perfect tetrahedral symmetry (bond angles 109.5°). Fig. 2 also shows the range of framework bond lengths, as the 6*c*-24*k* and 24*k*-24*k* bonds are the shortest and longest Ge-Ge bonds, respectively.

A powdered specimen from the Cu6 ingot placed on a grid for transmission-electron microscopy showed the characteristic cubic diffraction pattern (Inset of fig. 1). Diffraction images from several crystallites in this sample were compared to simulations, giving a good match to the observations. A superlattice structure was previously identified in Ba₈Ge₄₃, attributed to preferential ordering of the framework vacancies in that material.¹¹ We saw no evidence of a superlattice pattern in our samples, indicating the Cu atoms and vacancies to be randomly distributed on the 6*c* and 16*i* sites.

Compositional analysis was carried out using a commercial wavelength dispersive spectroscopy (WDS)-

TABLE I: Measured parameters for the three samples obtained from powder x-ray diffraction. 6*c* angle is the larger 24*k*-6*c*-24*k* bond angle.

Sample	Cu2	Cu4	Cu6
a (nm)	1.06987(1)	1.06916(2)	1.06872(1)
x	0.1829	0.1835	0.1830
y	0.3139	0.3150	0.3140
z	0.1201	0.1200	0.1196
6 <i>c</i> angle	110.2°	109.8°	109.9°
occupancy:			
Ba 2 <i>a</i>	1.00	1.00	0.93
Ba 6 <i>d</i>	1.00	0.99	0.97
Ge 6 <i>c</i>	0.09	0.10	0.10
Cu 6 <i>c</i>	0.82	0.81	0.88
Ge 16 <i>i</i>	1.00	0.99	0.97
Ge 24 <i>k</i>	1.00	1.00	1.00
Ba/cell	8.0	8.0	7.7
Cu/cell	4.9	4.9	5.3
Ge/cell	40.6	40.5	40.1
Cu+Ge vacancy	0.49	0.59	0.61

based electron microprobe apparatus and analysis system (Cameca). In these measurements the clathrate phase was identified in each sample, plus Ge, an oxide of approximate composition BaGeO₂, and Ge₃Cu₅ (Cu6 sample only). Although dispersed throughout the ingots, the latter two were below the x-ray detection limit. In the Cu4 sample a single localized Ge-Ba-S phase was detected, attributed to an impurity left after H₂SO₄ cleaning of the mortar and pestle, however no S was detected in any of the other analyses. The Ba-Ge oxide was not found to contain Cu in any of the samples.

X-ray and WDS analysis both provide a relative measure of the number of atoms per cell, rather than an absolute composition. We produced the compositions in Table I by assuming the largest site occupancy to be 100%. Scaling these results to lower values results quite quickly in vacancy concentrations which are unreasonable. For the Cu2 and Cu4 samples, this yields essentially 100% occupancy of the Ba sites, with framework vacancies appearing only on the 6*c* site. The Cu6-sample results are somewhat different, with vacancies appearing on the Ba 2*a* and framework 16*i* sites, as well as the framework 6*c* site. It appears that overloading the framework with Cu atoms forces vacancies to appear on the 16*i* site. The presence of Ba 2*a* vacancies is consistent with the behavior observed in Ba₈Si₄₆.¹⁸

In the Cu2 and Cu4 samples, diamond-structure Ge appeared as inclusions within the abundant clathrate phase, indicating a phase separation during the solid state reaction process. For Cu6, an additional phase was observed, of nominal composition GeCu_{1.65} or Ge₃Cu₅. (Diamond-Ge also contained about 1 at.% Cu.) Since the Cu content for Cu6 exceeded the clathrate stability limit, approximately 10% of the Cu appeared as Ge₃Cu₅ (or about 2 at.% of the entire sample), over and above the small change in Cu content of the clathrate. Ge₃Cu₅ has

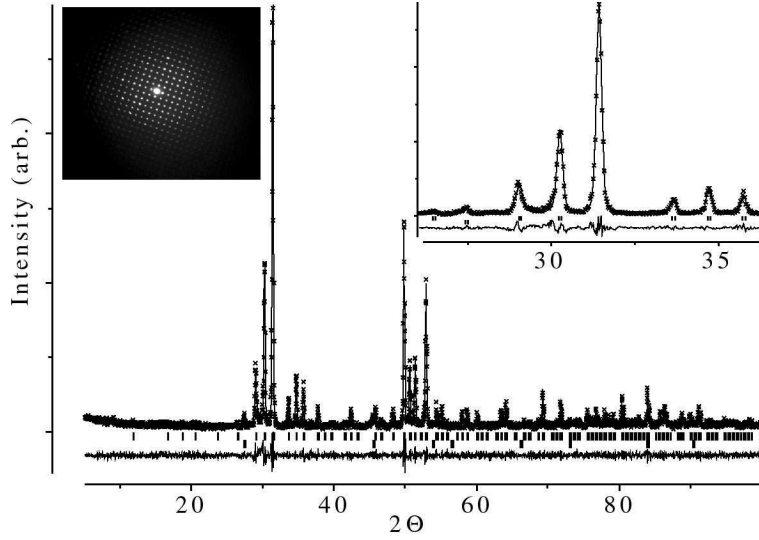


FIG. 1: Cu K- α powder x-ray pattern for the Cu2 sample (nominal composition $\text{Ba}_8\text{Cu}_2\text{Ge}_{44}$), with fit and difference plot. Inset at upper right is an expanded view. Vertical bars below the spectra indicate positions of clathrate-structure and Ge reflections. The inset at left shows an electron diffraction pattern for the Cu6 sample, showing a cubic pattern characteristic of the type-I clathrate, with no superlattice structure.

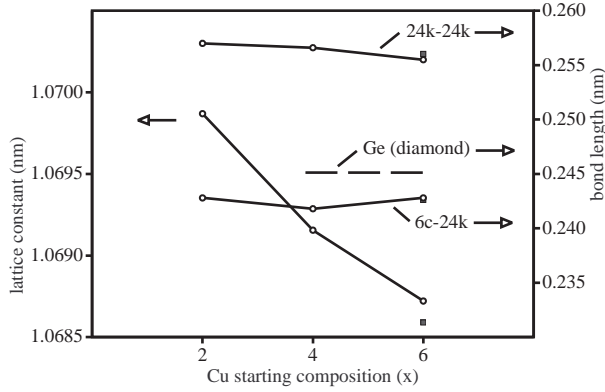


FIG. 2: Lattice constant and representative framework bond lengths versus nominal Cu composition. Near-neighbor bond length for diamond-structure Ge is shown by the dashed line. The shaded squares are from Ref. 10, for a sample of starting composition $x=6$.

not been previously reported to our knowledge,¹⁹ and this structure may be stabilized by the adjacent phases. None of the reported Ge-Cu intermetallic structures (GeCu_3 , GeCu_5 , Ge_2Cu_5) could be identified in the x-ray spectrum for the sample, nor could we identify reflections due to any other structures, within our resolution.

Fig. 3 shows M vs. H results for the Cu2 and Cu6 samples, obtained using a commercial SQUID magnetometer (Quantum Design, Inc.). The Cu6 sample exhibited diamagnetism at high temperatures, which we fit to $\chi_{dia} = -10.94(4) \times 10^{-7}$ emu/g (solid line in Fig. 3 for 300 K). At low temperatures the Cu6 sample also shows low-moment ferromagnetism, which we attribute to a dilute concentration of random defects.²⁰

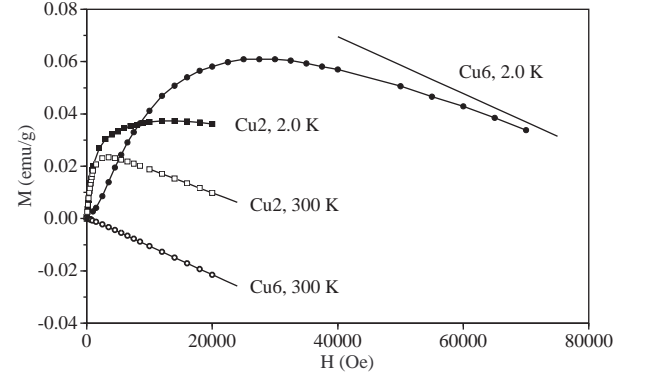


FIG. 3: M vs. H results for the Cu2 and Cu6 samples, at 2.0 K and 300 K as labeled. Error bars are smaller than the symbols. Solid lines through the 300 K data are least-squares fits, giving $\chi_{dia} = -10.94(4) \times 10^{-7}$ emu/g (Cu6) and $-9.02(4) \times 10^{-7}$ emu/g (Cu2). Solid curve above the Cu6, 2 K data has the same slope as the 300 K fit, showing slow saturation to this line. Curves connecting 2.0 K data are guides to the eye.

However, the high-field trend for the 2 K data is toward the same diamagnetic slope as at 300 K (upper line in Fig. 3), though some moments are not completely saturated in the 70 kOe maximum field of our magnetometer. The Cu2 sample has a weak ferromagnetic phase visible at 300 K, but above saturation the slope was fit to $\chi_{dia} = -9.02(4) \times 10^{-7}$ emu/g (solid line), very similar to that of the other sample. Thus we identify the Cu-Ge clathrate to exhibit bulk diamagnetism with a susceptibility of approximately -10×10^{-7} emu/g.

III. ANALYSIS AND DISCUSSION

The hypothetical empty-cage clathrates Si_{46} , Ge_{46} , and Sn_{46} are semiconducting as predicted by electronic-structure calculations.^{12,21,22} In filled Sn clathrates, the stable phase $\text{Cs}_8\text{Sn}_{44}$ has two vacancies per cell, in accordance with the classic Zintl concept,¹³ in which the number of valence electrons on the framework is preserved to give the most favorable bonding configuration, and hence a filled band and semiconducting behavior. Ternaries such as $\text{Cs}_8\text{Ga}_8\text{Sn}_{38}$ and $\text{Cs}_8\text{Zn}_4\text{Sn}_{42}$ can also clearly be treated this way.¹²

The stable Ba-Ge phase $\text{Ba}_8\text{Ge}_{43}$ ^{11,23} can be treated as a Zintl phase with incomplete charge transfer from nominally divalent Ba. However, the ionic character of Ba is less clear than that of the alkali metals, as there is evidence for mixing of the Ba $5d$ orbitals into the conduction band.^{22,24,25} On the other hand, for the Cu-Ge clathrate studied here, the valence counting argument works very well. If we assume Cu to have valence 1 and Ba valence 2, valence counting predicts the stable phase to be $\text{Ba}_8\text{Cu}_{(16/3)}\text{Ge}_{(46-16/3)} = \text{Ba}_8\text{Cu}_{5.3}\text{Ge}_{40.7}$. Or, if framework vacancies are allowed one obtains compositions such as $\text{Ba}_8\text{Cu}_5\text{Ge}_{40.75}$. These values are quite close to those observed in our samples (Table I).

The formation of vacancies is not necessary by this argument. However, the presence of Cu causes the lattice parameter to contract relative to the Ba-Ge clathrate. Since Cu cannot occupy all of the $6c$ sites by valence counting, some Ge atoms must occupy this site, having a neighbor distance smaller than that of elemental Ge (Fig. 2). Framework vacancies may allow this strain to be accommodated more easily. With an increased Cu concentration, the valence count can also be maintained by inducing Ba vacancies, as observed in Cu6. This attests to the strong stabilizing influence of the valence count, in contrast to the situation in the analogous Ag and Au clathrates.

There are other intermetallics in which the valence count influences the stability, although the Zintl concept would not normally apply. These would include a large class of semi-Heusler alloys such as TiNiSn , an intermetallic semiconductor.²⁶ However, in that case the adherence to valence count is not nearly so strong as in BaCuGe clathrate. What distinguishes the present case from other intermetallics is the fourfold-coordinated framework which enhances the stabilization of a local bonding configuration. This implies a rather ionic configuration for Cu, which would be more difficult to maintain for Au, and which may explain the distinction between the Cu and Au clathrate.

The Zintl mechanism implies a deep minimum or gap in the electron density of states at the Fermi level, which

is consistent with the large diamagnetic susceptibility that we have measured. This susceptibility is four times larger than observed for the Au clathrate,¹¹ and larger than of other group-IV clathrates of which we are aware. Per framework site, the susceptibility of the Cu6 sample is -95×10^{-6} emu/mol, comparable to that of the largest elemental diamagnets,²⁷ and considerably larger than the value (-13×10^{-6} emu/mol or -1.4×10^{-7} emu/g) we obtain for the core susceptibility using standard parameters.²⁸

In tetrahedrally-bonded elemental semiconductors, there is a near-cancellation of the paramagnetic and diamagnetic susceptibilities. A model for this behavior²⁹ indicates that the valence contribution to the diamagnetic susceptibility scales with $\langle r^2 \rangle$, as for molecular systems. However, the expansion of the clathrate framework relative to the zinc-blende lattice does not appear sufficient to explain the large magnitude of the diamagnetic susceptibility observed here. Furthermore, though there are structural similarities to graphite, we do not expect the clathrates to have the conjugated orbitals which give ring currents in aromatic molecules.²⁸ On the other hand, recent measurements³⁰ have shown a large diamagnetic response for the semimetal RuAl_2 , as well as other intermetallic semiconductor systems such as the skutterudite CoSb_3 . The mechanism for this is not known, however it seems likely that the Cu clathrate is on the same footing with these systems, and exhibits a narrow gap or pseudogap at the Fermi surface.

IV. CONCLUSIONS

We have prepared type-I clathrates from different starting Ba-Cu-Ge compositions, and find a preferred composition with the Cu content close to 5, rather than 6, per cell. Furthermore, the composition adheres rather tightly to a valence-counting scheme, which we attribute to the Zintl mechanism, in contrast to the Au and Ag analogs. This implies a semimetallic or semiconducting characteristic, contrasting the reported metallic behavior of the Au clathrate. A very large diamagnetic susceptibility was also observed, which matches the behavior of other semiconducting and semimetallic intermetallics.

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¹ G. K. Ramachandran, J. J. Dong, J. Diefenbacher, J. Gryko, R. F. Marzke, O. F. Sankey, and P. F. McMillan,

J. Solid State Chem. **145**, 716 (1999).

- ² G. S. Nolas, T. J. R. Weakley, J. L. Cohn, and R. Sharma, *Phys. Rev. B* **61**, 3845 (2000).
- ³ G. S. Nolas, B. C. Chakoumakos, B. Mahieu, G. J. Long, and T. J. R. Weakley, *Chem. Mater.* **12**, 1947 (2000).
- ⁴ S. Yamanaka, E. Enishi, and H. Fukuoka, *Inorg. Chem.* **39**, 56 (2000).
- ⁵ J. D. Bryan, *Phys. Rev. B* **60**, 3064 (1999).
- ⁶ T. Kawaguchi, K. Tanigaki, and M. Yasukawa, *Appl. Phys. Lett.* **77**, 3438 (2000).
- ⁷ J. Gryko, P. F. McMillan, and R. F. Marzke, *Phys. Rev. B* **62**, R7707 (2000).
- ⁸ J. L. Cohn, G. S. Nolas, V. Fessatidis, T. H. Metcalf, and G. A. Slack, *Phys. Rev. Lett.* **82**, 779 (1999).
- ⁹ S. Munetoh, K. Moriguchi, K. Kamei, A. Shintani, and T. Motooka, *Phys. Rev. Lett.* **86**, 4879 (2001).
- ¹⁰ G. Cordier and P. Woll, *J. Less-Common Met.* **169**, 291 (1991).
- ¹¹ R. F. W. Herrmann, K. Tanigaki, T. Kawaguchi, S. Kuroshima, and O. Zhou, *Phys. Rev. B* **60**, 13245 (1999).
- ¹² C. W. Myles, J. Dong, and O. F. Sankey, *Phys. Rev. B* **64**, 165202 (2001).
- ¹³ S. M. Kauzlarich, ed., *Chemistry, Structure, and Bonding of Zintl Phases and Ions* (VCH, 1996).
- ¹⁴ R. F. W. Herrmann, K. Tanigaki, S. Kuroshima, and H. Suematsu, *Chem. Phys. Lett.* **283**, 29 (1998).
- ¹⁵ Y. Nozue, G. Hosaka, E. Enishi, and S. Yamanaka, *Mol. Cryst. Liq. Cryst.* **341**, 509 (2000).
- ¹⁶ A. C. Larson and R. B. von Dreele, *Tech. Rep. LAUR 86-748*, Los Alamos National Laboratory (2000).
- ¹⁷ B. H. Toby, *J. Appl. Cryst.* **34**, 210 (2001).
- ¹⁸ A. Kitano, K. Moriguchi, M. Yonemura, S. Munetoh, A. Shintani, H. Fukuoka, S. Yamanaka, E. Nishibori, M. Takata, and M. Sakata, *Phys. Rev. B* **64**, 045206 (2001).
- ¹⁹ P. Villars and L. D. Calvert, *Pearson's handbook of crystallographic data for intermetallic phases* (ASM International, 1991).
- ²⁰ Y. Li, W. Gou, J. Chi, and J. H. Ross, Jr., unpublished.
- ²¹ J. Zhao, A. Buldum, J. P. Lu, , and C. Y. Fong, *Phys. Rev. B* **60**, 14177 (1999).
- ²² S. Saito and A. Oshiyama, *Phys. Rev. B* **51**, 2628 (1995).
- ²³ W. Carrillo-Cabrera, J. Curda, K. Peters, S. Paschen, M. Baenitz, Y. Grin, and H. G. von Schnering, *Z. Kristall.* **215**, 321 (2000).
- ²⁴ K. Moriguchi, S. Munetoh, and A. Shintani, *Phys. Rev. B* **62**, 7138 (2000).
- ²⁵ N. P. Blake, D. Bryan, S. Lattner, L. Mollnitz, G. D. Stucky, and H. Metiu, *J. Chem. Phys.* **114**, 10063 (2001).
- ²⁶ J. Tobola, J. Pierre, S. Kaprzyk, R. V. Skolozdra, and M. A. Kouacou, *J. Phys. Condens. Matter* **10**, 1013 (1998).
- ²⁷ in *American Institute of Physics Handbook, Third Edition*, edited by D. E. Gray (McGraw Hill, 1972), pp. 5–224.
- ²⁸ L. N. Mulay, in *Theory and Applications of Molecular Diamagnetism*, edited by L. N. Mulay and E. A. Boudreaux (Wiley, 1976).
- ²⁹ S. Hudgens, M. Kastner, and H. Fritzsche, *Phys. Rev. Lett.* **33**, 1552 (1974).
- ³⁰ D. Mandrus, V. Keppens, B. C. Sales, and J. L. Sarrao, *Phys. Rev. B* **58**, 3712 (1998).